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New Technologies for Data Mining and Data Analysis

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Deadline for manuscript submissions:

closed (15 March 2024)

Message from the Guest Editor

Dear Colleagues,

Electronics aims to dedicate a Special Issue on new technologies for data mining and data analysis, and researchers are warmly encouraged to submit papers on topics such as AI and ML models in complex patterns, prediction modeling, and automated decision making; big data processing technologies; cloud computing; edge computing, NLP; graph analytics; data visualization technologies; automated hybrid approaches, explainable AI in (e.g., business analytics, healthcare and medical research, fraud detection and risk management, social media analysis, Internet of Things (IoT) analytics, environmental analysis, cybersecurity, transportation and logistics, smart cities and urban planning.)

These new technologies can evolve to drive advancements in data mining and analysis, enabling organizations to extract valuable insights, make data-driven decisions, and gain a competitive edge in today's data-driven landscape.











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Message from the Editor-in-Chief

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